







INA2128 JAJSQ08B - DECEMBER 1995 - REVISED MAY 2023

INA2128 デュアル、低消費電力計測アンプ

1 特長

- 低いオフセット電圧:50µV(最大値)
- 低いドリフト:0.5µV/℃ (最大値)
- 低い入力バイアス電流:5nA (最大値)
- 入力電圧ノイズ:1kHz で 8nV/√Hz
- 広い帯域幅:GDIFF = 1V/V で 1.3MHz
- 高い CMR: 120dB (最小値)
- ±40V までの入力保護
- 広い電源電圧範囲:±2.25V~±18V
- 低い静止電流:700µA (チャネルあたり)
- 温度範囲:-40℃~+85℃
- パッケージ:16 ピン SOIC

2 アプリケーション

- 圧力トランスミッタ
- 温度トランスミッタ
- 重量計
- 心電図 (ECG)
- アナログ入力モジュール
- データ・アクイジション (DAQ)

3 概要

INA2128 は、精度の優れた低消費電力のデュアル汎用 計測アンプ (IA) です。本デバイスは、用途が広い 3 オペ アンプ設計を採用しており、サイズが小型であるため、広 範なアプリケーションに非常に適しています。電流帰還入 力回路により、高いゲインでも広い帯域幅が得られます (G = 100 で 200kHz)。単一の外付け抵抗により、1~ 10,000 の範囲で任意のゲインを設定できます。内部入力 保護機能は、損傷なしに ±40V まで耐えられます。

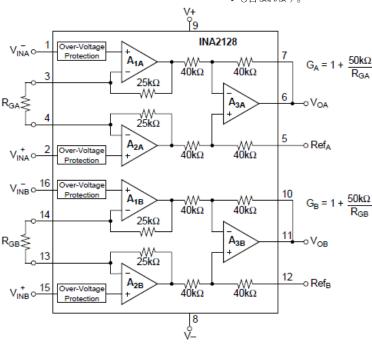
INA2128 はレーザー・トリムにより、非常に低いオフセット 電圧 (50µV) とドリフト係数 (0.5µV/℃)、高い同相除去 (G ≥ 100 で 120dB) を実現しています。このデバイスは最低 ±2.25V の電源で動作し、静止電流は IA あたりわずか 700µA であるため、バッテリ駆動の複数チャネル・システ ムに理想的です。

INA2128 は、SOIC-16 パッケージで供給され、-40℃~ +85℃で動作が規定されています。

パッケージ情報

部品番号		パッケージ ⁽¹⁾	パッケージ・サイズ ⁽²⁾
	INA2128	DW (SOIC, 16)	10.3mm x 10.3mm

- 利用可能なパッケージについては、このデータシートの末尾にあ る注文情報を参照してください。
- パッケージ・サイズ (長さ×幅) は公称値であり、該当する場合はピ ンも含まれます。



概略回路図



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4 Revision History

資料番号末尾の英字は改訂を表しています。その改訂履歴は英語版に準じています。

	では、一般には、一般には、一般には、一般には、一般には、一般には、一般には、一般に	
С	changes from Revision A (April 2007) to Revision B (May 2023)	Page
•	ドキュメント全体にわたって表、図、相互参照の採番方法を更新	1
•	「パッケージ情報」表、「ピン構成および機能」セクション、「仕様」セクション、「詳細説明」セクション、「アプリケーシ	
	と実装」セクション、「デバイスおよびドキュメントのサポート」セクション、「メカニカル、パッケージ、および注文情報	」と
	クションを追加	
•	「特長」に入力電圧ノイズ、高帯域幅、および温度範囲の箇条書き項目を追加	1
•	正しいパッケージ名を示すように「特長」の箇条書き項目を変更	1
•	更新されたリンクを示すよう「アプリケーション」の箇条書き項目を変更	
•	「パッケージ情報」表の列名を本体サイズ (NOM) からパッケージ・サイズに変更し、パッケージ・サイズに関する活	主を
	追加	1
•	Added single supply specification to Absolute Maximum Ratings	5
•	Added note clarifying output short-circuit to ground in Absolute Maximum Ratings refers to short-circuit to)
	VS / 2	5
•	Added single supply specification to Recommended Operating Conditions	5
•	Changed input common-mode voltage range specification from V – 2 to (V–) + 2 in Recommended Oper	
	Conditions	5
•	Deleted INA128-HT and INA129-HT operating temperature specifications from Recommended Operating	7
	Conditions	5
•	Added specified temperature range to Recommended Operating Conditions	
•	Added test conditions below Electrical Characterstics title	
•	Changed test condition for offset voltage drift specification in <i>Electrical Characteristics</i> from "TA = TMIN to	Ю.
	TMAX" to " TA = -40 °C to $+85$ °C" for clarity	6
•	Changed "±0.5±0/G" to "±0.5±20/G" in MAX column of Offset voltage RTI vs temperature row of <i>Electrica</i>	<i>al</i>
	Characteristics	6
•	Changed typical long-term stability specification from ±0.1±3/GμV/mo to ±0.2±3/GμV/mo in <i>Electrical</i>	_
	Characteristics	6
•	Deleted typical specification and changed common-mode voltage specification from (V–) + 2 V minimum	
	(V+) – 2 V maximum across one row in Electrical Characteristics	
•	Deleted typical VCM specifications in <i>Electrical Characteristics</i>	
•	Added test condition of "RS = 0 Ω " to safe input voltage specification in <i>Electrical Characteristics</i> for clari	ιy
	Changed parameter name to Input bias current and added test condition "TA = -40 °C to +85°C" to input	hiae
	current drift specification in <i>Electrical Characteristics</i> for clarity	
	Changed parameter name to Input offset current drift and added test condition "TA = -40 °C to +85°C" to	
	offset current drift specification in <i>Electrical Characteristics</i> for clarity	



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•	Changed maximum gain error specification for INA128PA/UA and INA129PA/UA with G = 1 from ±0.01% to	0
	±0.1% in <i>Electrical Characteristics</i>	0
	Electrical Characteristics for clarity	6
•	Changed parameter names from "Voltage - Positive" to "Positive output voltage swing" and from "Voltage - Negative" to "Negative output voltage swing" in <i>Electrical Characteristics</i>	
•	Deleted typical positive and negative output voltage swing specifications in Electrical Characteristics	
•	Added test condition "Continuous to VS / 2" short-circuit current specification in <i>Electrical Characteristics</i>	
	for clarity	6
•	Changed typical bandwidth specification for G = 10 from 700 kHz to 600 kHz in <i>Electrical Characteristics</i>	6
•	Changed typical slew rate specification from 4 V/µs to 1.2 V/µs in <i>Electrical Characteristics</i>	6
•	Changed typical settling time specification for $G = 1$, $G = 10$, from 7 μs to 9 μs in <i>Electrical Characteristics</i>	
	Deleted parameter "Temperature Range" as made redundant by "Recommended Operating Conditions" ar	<mark>0</mark>
•	"Absolute Maximum Ratings"	1U 6
	Changed parameter name to "Total quiescent current" and deleted redundant voltage range, operating	0
	temperature range, and specification temperature range specifications from <i>Electrical Characteristics</i>	6
•	Added test conditions below the Typical Characteristics title	
•	Changed Figure 6-1, Gain vs Frequency	
•	Changed Figure 6-3, Positive Power Supply Rejection vs Frequency	8
•	Changed Figure 6-4, Negative Power Supply Rejection vs Frequency	
•	Changed Figure 6-7, Crosstalk vs Frequency	
•	Changed Figure 6-8, Input-Referred Voltage Noise vs Frequency	
•	Changed Figure 6-9, Settling Time vs Gain	
•	Changed Figure 6-11, Input Overvoltage V/I Characteristics	8
•	Changed Figure 6-12, Offset Voltage Warm-Up	8
•	Changed <i>Output Voltage Swing vs Output Current</i> , into two separate plots, one for positive (Figure 6-14) a	
	one for negative (Figure 6-15)	
-	Onanged inguie 0-22 to inguie 0-24, Large-Digital Step Nesponse	0



5 Pin Configuration and Functions

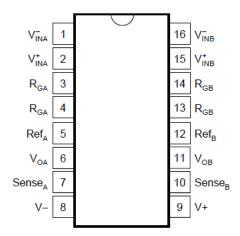


図 5-1. DW Package, 16-Pin SOIC (Top View)

6 Specifications

6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)(1)

			MIN	MAX	UNIT
V _S	Supply voltage	Dual supply, $V_S = (V+) - (V-)$		±18	V
VS	Supply voltage	Single supply, $V_S = (V+) - 0 V$		36	V
	Analog input voltage			±40	V
	Output short-circuit ⁽²⁾		Continuous		
T _A	Operating temperature	9	-40	125	°C
	Junction temperature			150	°C
	Lead temperature (sol	dering, 10 s)		300	°C
T _{stg}	Storage temperature		-55	125	°C

⁽¹⁾ Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

6.2 ESD Ratings

			VALUE	UNIT
V	Electrostatic discharge	Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 ⁽¹⁾		V
V _(ESD)	Electrostatic discriarge	Charged-device model (CDM), per JEDEC specification JESD22-C101 ⁽²⁾		\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \

⁽¹⁾ JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

			MIN	TYP	MAX	UNIT
\/_	Supply voltage	Single-supply		30	36	V
Vs	Supply voltage	Dual-supply	±2.25	±15	±18	\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \
	Input common-mode voltage range for	V _O = 0 V	(V-) + 2		(V+) – 2	V
T _A	Specified temperature		-40		85	°C

6.4 Thermal Information

		INA	12x	
	THERMAL METRIC ⁽¹⁾	D (SOIC)	P (PDIP)	UNIT
		8 PINS	8 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	110	46.1	°C/W
R _{0JC(top)}	Junction-to-case (top) thermal resistance	57	34.1	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	54	23.4	°C/W
ΨЈТ	Junction-to-top characterization parameter	11	11.3	°C/W
ΨЈВ	Junction-to-board characterization parameter	53	23.2	°C/W

⁽¹⁾ For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report.

⁽²⁾ Short-circuit to V_S / 2.

⁽²⁾ JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.



6.5 Electrical Characteristics

at T_A = 25°C, V_S = ±15 V, R_L = 10 k Ω , V_{REF} = 0 V, V_{CM} = V_S / 2, and G = 1 (unless otherwise noted)

	DADAMETED.			010	, and	T)(D	BAAY	LINUT
	PARAMETER	TES	T CONDIT	ONS	MIN	TYP	MAX	UNIT
INPUT	1	1						
V _{OS} Offset voltage (RTI)		INA2128U		±10 ±100 / G	±50 ±500 / G	μV		
	g- (····)	INA2128UA				±25 ±100 / G	±125 ±1000 / G	F
	Offset voltage drift (RTI)	$T_A = -40^{\circ}\text{C to } +85^{\circ}\text{C}$	INA2128U			±0.2 ±2 / G	±0.5 ±20 / G	μV/°C
	Onder Voltage unit (1771)	14 10 0 10 100 0	INA2128U	A		±0.2 ±5 / G	±1 ±20 / G	μν, σ
PSRR	Power-supply rejection	V _S = ±2.25 V to ±18 V	INA2128U			±0.2 ±20 / G	±1 ±100 / G	μV/V
TORK	ratio (RTI)	V5 - 12.25 V to 110 V	INA2128U	A		±0.2 ±20 / G	±2 ±200 / G	μν/ν
	Long-term stability					±0.2 ±3 / G		μV/mo
	Input impedance	Differential				10 2		GΩ pF
	input impedance	Common-mode				100 9		Gtz þF
V _{CM}	Common-mode voltage ⁽¹⁾	V _O = 0 V			(V-) + 2		(V+) – 2	V
	Safe input voltage	R _S = 0 Ω					±40	V
			0 - 4	INA2128U	80	86		
	Common-mode rejection ratio	tion AP = 1k0 V = ±12 V	G = 1	INA2128UA	73	86		dB
			G = 10	INA2128U	100	106		
OMBB				INA2128UA	93	106		
CMRR		$\Delta R_S = 1 \text{ k}\Omega, V_{CM} = \pm 13 \text{ V}$	G = 100	INA2128U	120	125		
				INA2128UA	110	125		
				INA2128U	120	130		
			G = 1000	INA2128UA	110	130		
INPUT E	BIAS CURRENT		'		<u> </u>			
		INA2128U				±2	±5	•
I _B	Input bias current	INA2128UA		±2	±10	nA		
	Input bias current drift	T _A = -40°C to +85°C				±30		pA/°C
		INA2128U				±1	±5	•
los	Input offset current	INA2128UA				±1	±10	nA
	Input offset current drift	T _A = -40°C to +85°C				±30		pA/°C
NOISE	1							
			f = 10 Hz			10		
		0 4000 D 0 0	f = 100 Hz			8		nV/√ Hz
e _N	Voltage noise (RTI)	$G = 1000, R_S = 0 Ω$	f = 1 kHz			8		
		f _B = 0.1 Hz to 10 Hz				0.2		μV _{PP}
		f = 10 Hz	1			0.9		m ∧ / ./ 1] -
	Current noise	f = 1 kHz				0.3		pA/√ Hz
		f _B = 0.1 Hz to 10 Hz				30		pA _{PP}
	1	1						

Product Folder Links: INA2128

6.5 Electrical Characteristics (continued)

at $T_A = 25$ °C, $V_S = \pm 15$ V, $R_L = 10$ k Ω , $V_{REF} = 0$ V, $V_{CM} = V_S / 2$, and G = 1 (unless otherwise noted)

	PARAMETER	Т	EST CONDITIONS	MIN	TYP	MAX	UNIT		
GAIN									
	Gain equation			1	+ (50 kΩ / R _G)		V/V		
G	Gain			1		10000	V/V		
		G = 1	INA2128U		±0.01	±0.024			
		G=1	INA2128UA		±0.01	±0.1			
		G = 10	INA2128U		±0.02	±0.4	1		
GE	Cain arrar	G = 10	INA2128UA		±0.02	±0.5	%		
GE	Gain error	G = 100	INA2128U		±0.05	±0.5	70		
		G = 100	INA2128UA		±0.05	±0.7			
		C = 1000	INA2128U		±0.5	±1			
		G = 1000	INA2128UA		±0.5	±2			
	O - i d - i # (2)	T - 40°C t- 105°C			±1	±10	ppm/°C		
	Gain drift ⁽²⁾	$T_A = -40^{\circ}C \text{ to } +85^{\circ}C$	50-kΩ or 49.4-kΩ resistance ⁽³⁾		±25	±100			
		0 - 4 1/ - 140 01/	INA2128U		±0.0001	±0.001			
		$G = 1, V_O = \pm 13.6 V$	INA2128UA		±0.0001	±0.002			
		0 40	INA2128U		±0.0003	±0.002	% of FSR		
	Gain nonlinearity	G = 10	INA2128UA		±0.0003	±0.004			
		0 400	INA2128U		±0.0005	±0.002			
		G = 100	INA2128UA		±0.0005	±0.004			
		G = 1000 ⁽⁴⁾			±0.001				
OUTP	UT			<u> </u>					
	Positive output voltage			(V+) - 1.4			V		
	Negative output voltage			(V-) + 1.4			V		
C _L	Load capacitance	Stable operation			1000		pF		
I _{SC}	Short-circuit current	Continuous to V _S / 2			+6/–15		mA		
FREQ	UENCY RESPONSE								
		G = 1			1.3		MHz		
DW	D	G = 10			600				
BW	Bandwidth, –3 dB	G = 100			200		kHz		
		G = 1000			20				
SR	Slew rate	G = 10, V _O = ±10 V			1.2		V/µs		
			G = 1		9				
	0 - 411: 41:	T- 0.040/	G = 10		9		μs		
t _S	Settling time	To 0.01%	G = 100		12				
			G = 1000		80				
	Overload recovery	50% input overload	·		4		μs		
POWE	R SUPPLY	1		<u> </u>					
IQ	Total quiescent current	V _{IN} = 0 V			±1.4	±1.5	mA		

Input common-mode voltage varies with output voltage; see *Typical Characteristics*.

⁽²⁾ Specified by wafer test.

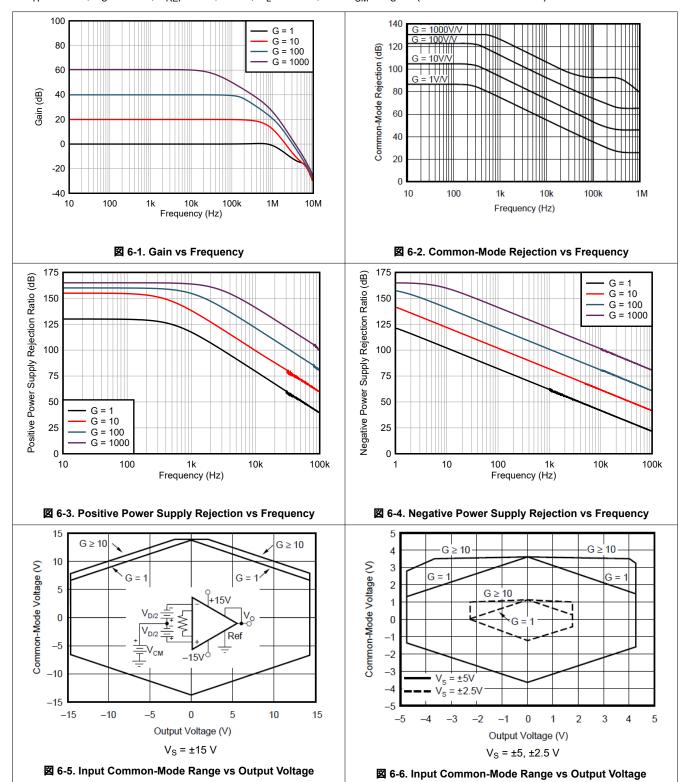
⁽³⁾ (4) Temperature coefficient of the 50-k Ω or 49.4-k Ω term in the gain equation.

Nonlinearity measurements in G = 1000 are dominated by noise. Typical nonlinearity is ±0.001%.



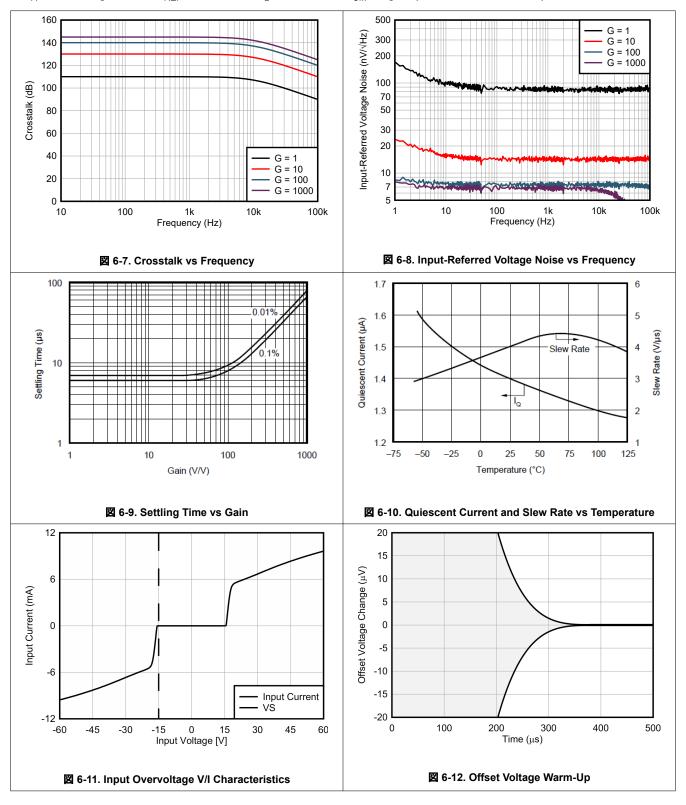
6.6 Typical Characteristics

at T_A = +25°C, V_S = ±15 V, V_{REF} = 0 V, G = 1, R_L = 10 k Ω , and V_{CM} = V_S / 2 (unless otherwise noted)



6.6 Typical Characteristics (continued)

at T_A = +25°C, V_S = ±15 V, V_{REF} = 0 V, G = 1, R_L = 10 k Ω , and V_{CM} = V_S / 2 (unless otherwise noted)





12

15

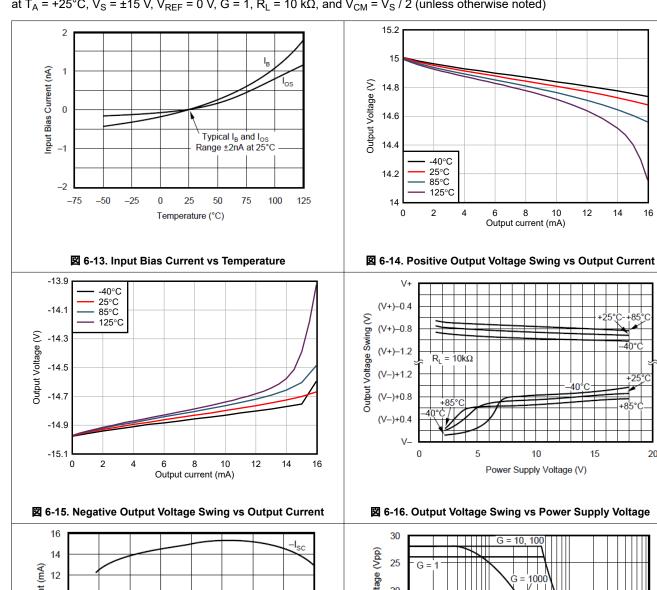
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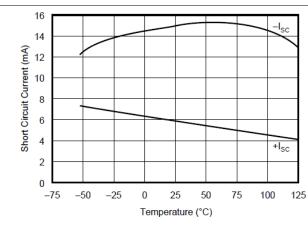
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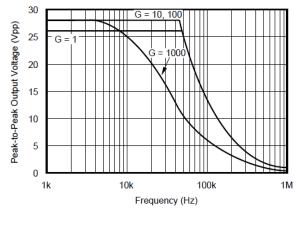
6.6 Typical Characteristics (continued)

at T_A = +25°C, V_S = ±15 V, V_{REF} = 0 V, G = 1, R_L = 10 k Ω , and V_{CM} = V_S / 2 (unless otherwise noted)





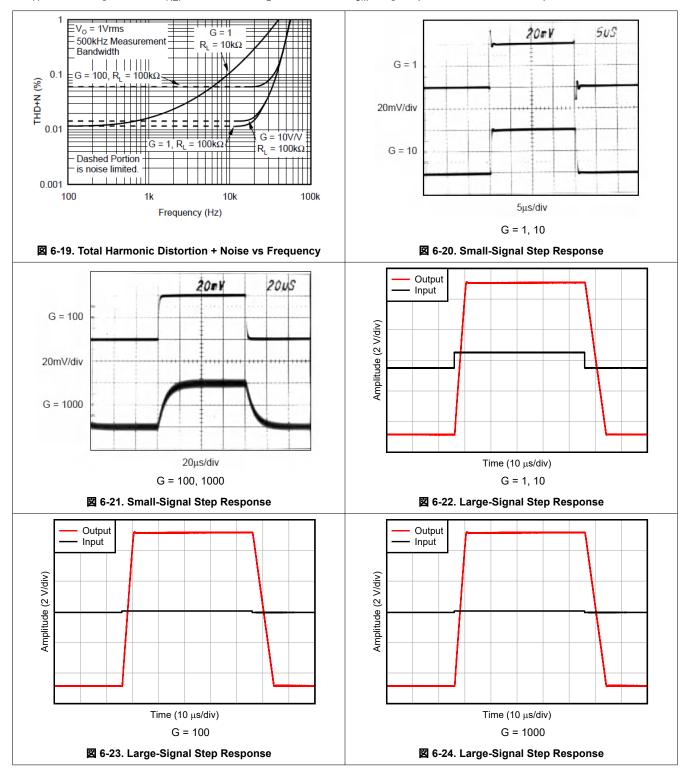
☑ 6-17. Short-Circuit Output Current vs Temperature



☑ 6-18. Maximum Output Voltage vs Frequency

6.6 Typical Characteristics (continued)

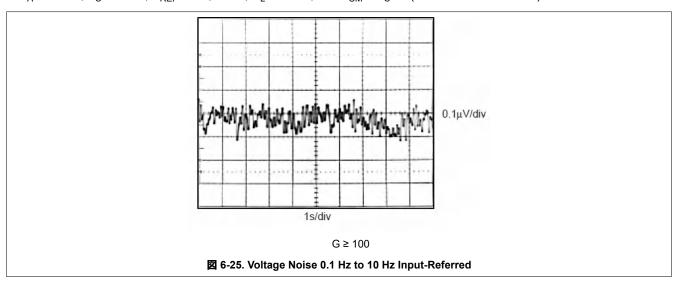
at T_A = +25°C, V_S = ±15 V, V_{REF} = 0 V, G = 1, R_L = 10 k Ω , and V_{CM} = V_S / 2 (unless otherwise noted)





6.6 Typical Characteristics (continued)

at T_A = +25°C, V_S = ± 15 V, V_REF = 0 V, G = 1, R_L = 10 k Ω , and V_CM = V_S / 2 (unless otherwise noted)



7 Application and Implementation

注

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

7.1 Application Information

☑ 7-1 shows the basic connections required for operation of the INA2128. Applications with noisy or high impedance power supplies may require decoupling capacitors close to the device pins as shown.

The output is referred to the output reference (Ref) terminals (Ref_A and Ref_B) which are normally grounded. These must be low-impedance connections to assure good common-mode rejection. A resistance of 8 Ω in series with a Ref pin will cause a typical device to degrade to approximately 80 dB CMR (G = 1).

The INA2128 has separate output sense feedback connections, Sense_A and Sense _B. These must be connected to their respective output terminals for proper operation. The output sense connection can be used to sense the output voltage directly at the load for best accuracy.

7.2 Typical Application

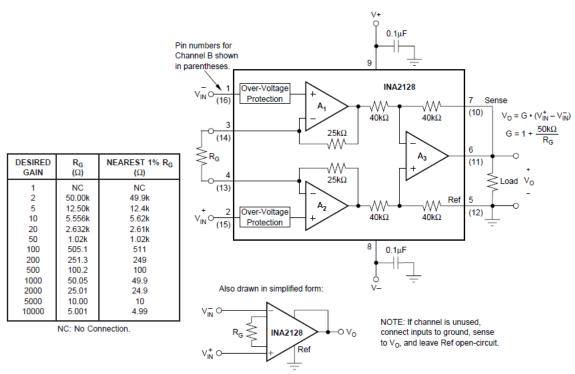


図 7-1. Basic Connections



7.2.1 Setting The Gain

Gain of the INA2128 is set by connecting a single external resistor, RG, connected as shown:

$$G = 1 + \frac{50 k\Omega}{R_G}$$
 (1)

Commonly-used gains and resistor values are shown in **Z** 7-1.

The 50 k Ω term in $\not \equiv 1$ comes from the sum of the two internal feedback resistors, A₁ and A₂. These on-chip metal film resistors are laser-trimmed to accurate absolute values. The accuracy and temperature coefficient of these resistors are included in the gain accuracy and drift specifications of the INA2128.

The stability and temperature drift of the external gain setting resistor, RG, also affects gain. RG's contribution to gain accuracy and drift can be directly inferred from the gain equation (1). Low resistor values required for high gain can make wiring resistance important. Sockets add to the wiring resistance which will contribute additional gain error in gains of approximately 100 or greater.

7.2.2 Dynamic Performance

The typical performance curve \boxtimes 6-1 shows that despite its low quiescent current, the INA2128 achieves wide bandwidth, even at high gain. This is due to its current feedback topology. Settling time also remains excellent at high gain—see \boxtimes 6-9.

7.2.3 Noise Performance

The INA2128 provides very low noise in most applications. Low frequency noise is approximately 0.2 μ V_{pp} measured from 0.1 Hz to 10 Hz (G \geq 100). This provides dramatically improved noise when compared to state-of-the-art chopper-stabilized amplifiers.

7.2.4 Offset Trimming

The INA2128 is laser-trimmed for low offset voltage and offset voltage drift. Most applications require no external offset adjustment. Z 7-2 shows an optional circuit for trimming the output offset voltage. The voltage applied to Ref terminal is summed with the output. The op amp buffer provides low impedance at the Ref terminal to preserve good common-mode rejection.

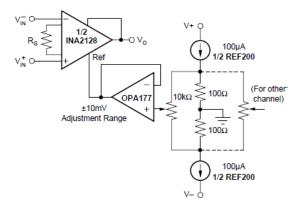


図 7-2. Optional Trimming of Output Offset Voltage

Submit Document Feedback

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7.2.5 Input Bias Current Return Path

The input impedance of the INA2128 is extremely high—approximately $10^{10}~\Omega$. However, a path must be provided for the input bias current of both inputs. This input bias current is approximately $\pm 2~\text{nA}$. High input impedance means that this input bias current changes very little with varying input voltage.

Input circuitry must provide a path for this input bias current for proper operation. Z 7-3 shows various provisions for an input bias current path. Without a bias current path, the inputs float to a potential that exceeds the common-mode range of the INA2128 and the input amplifiers saturate.

If the differential source resistance is low, the bias current return path can be connected to one input (see the thermocouple example in \boxtimes 7-3). With higher source impedance, using two equal resistors provides a balanced input with possible advantages of lower input offset voltage due to bias current and better high-frequency common-mode rejection.

7.2.6 Input Common-Mode Range

The linear input voltage range of the input circuitry of the INA2128 is from approximately 1.4 V less than the positive supply voltage to 1.7 V greater than the negative supply. As a differential input voltage causes the output voltage increase, the linear input range is limited by the output voltage swing of amplifiers A_1 and A_2 . Therefore, the linear common-mode input range is related to the output voltage of the complete amplifier. This behavior also depends on supply voltage—see performance curves \boxtimes 6-6 and \boxtimes 6-5.

Input-overload can produce an output voltage that appears normal. For example, if an input overload condition drives both input amplifiers to the positive output swing limit, the difference voltage measured by the output amplifier is near zero. The output of the INA2128 is near 0 V even though both inputs are overloaded.

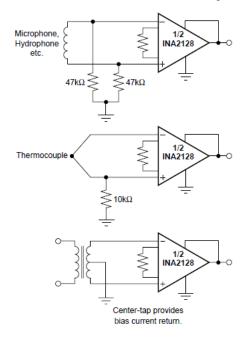


図 7-3. Providing an Input Common-Mode Current Path

7.2.7 Low-Voltage Operation

The INA2128 can be operated on power supplies as low as ± 2.25 V. Performance remains excellent with power supplies ranging from ± 2.25 V to ± 18 V. Most parameters vary only slightly throughout this supply voltage range —see ± 2.25 V to ± 1.8 V. Most parameters vary only slightly throughout this supply voltage range range voltages remain within the linear range. Voltage swing requirements of internal nodes limit the input common-mode range with low power-supply voltage. Typical performance curves, \boxtimes 6-5 and \boxtimes 6-6, show the range of linear operation for ± 1.5 -V, ± 5 -V, and ± 2.5 -V supplies.

7.2.8 Input Protection

The inputs of the INA2128 are individually protected for voltages up to ±40 V. For example, a condition of –40 V on one input and +40 V on the other input will not cause damage. Internal circuitry on each input provides low series impedance under normal signal conditions. To provide equivalent protection, series input resistors would contribute excessive noise. If the input is overloaded, the protection circuitry limits the input current to a safe value of approximately 1.5 mA to 5 mA. The typical performance curve "Input Bias Current vs Common-Mode Input Voltage" shows this input current limit behavior. The inputs are protected even if the power supplies are disconnected or turned off.

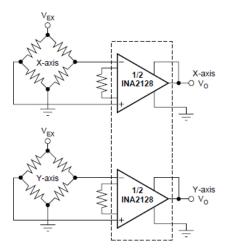


図 7-4. Two-Axis Bridge Amplifier

7.2.9 Channel Crosstalk

The two channels of the INA2128 are completely independent, including all bias circuitry. At dc and low frequency, there is virtually no signal coupling between channels. Crosstalk increases with frequency and depends on circuit gain, source impedance, and signal characteristics.

As source impedance increases, careful circuit layout helps achieve lowest channel crosstalk. Most crossstalk is produced by capacitive coupling of signals from one channel to the input section of the other channel. To minimize coupling, separate the input traces as far as practical from any signals associated with the opposite channel. A grounded guard trace surrounding the inputs helps reduce stray coupling between channels. Run the differential inputs of each channel parallel to each other or directly adjacent on top and bottom side of a circuit board. Stray coupling then tends to produce a common-mode signal which is rejected by the IA input.

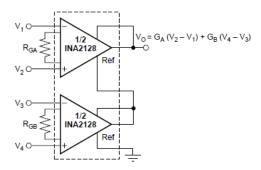


図 7-5. Sum of Differences Amplifier

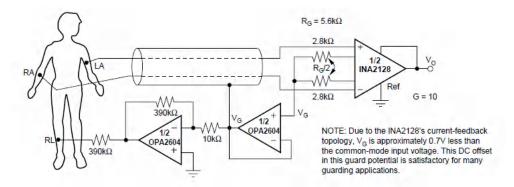


図 7-6. ECG Amplifier With Right-Leg Drive



8 Device and Documentation Support

TI offers an extensive line of development tools. Tools and software to evaluate the performance of the device, generate code, and develop solutions are listed below.

8.1 ドキュメントの更新通知を受け取る方法

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8.2 サポート・リソース

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ESD による破損は、わずかな性能低下からデバイスの完全な故障まで多岐にわたります。精密な IC の場合、パラメータがわずかに変化するだけで公表されている仕様から外れる可能性があるため、破損が発生しやすくなっています。

8.5 用語集

テキサス・インスツルメンツ用語集 この用語集には、用語や略語の一覧および定義が記載されています。

9 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

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PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
INA2128U	ACTIVE	SOIC	DW	16	40	RoHS & Green	NIPDAU	Level-3-260C-168 HR	-40 to 85	INA2128U	Samples
INA2128U/1K	ACTIVE	SOIC	DW	16	1000	RoHS & Green	NIPDAU	Level-3-260C-168 HR		INA2128U	Samples
INA2128UA	ACTIVE	SOIC	DW	16	40	RoHS & Green	NIPDAU	Level-3-260C-168 HR		(INA2128U, INA2128 UA) A	Samples
INA2128UA/1K	ACTIVE	SOIC	DW	16	1000	RoHS & Green	NIPDAU	Level-3-260C-168 HR		(INA2128U, INA2128 UA) A	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

⁽³⁾ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

⁽⁴⁾ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

⁽⁵⁾ Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

⁽⁶⁾ Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.



PACKAGE OPTION ADDENDUM

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In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

PACKAGE MATERIALS INFORMATION

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TAPE AND REEL INFORMATION



TAPE DIMENSIONS + K0 - P1 - B0 W Cavity - A0 -

A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE

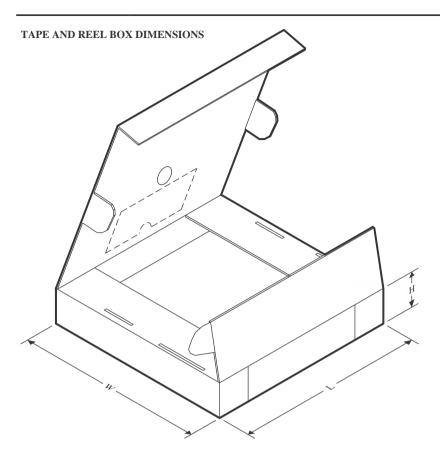


*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
INA2128U/1K	SOIC	DW	16	1000	330.0	16.4	10.75	10.7	2.7	12.0	16.0	Q1
INA2128U/1K	SOIC	DW	16	1000	330.0	16.4	10.75	10.7	2.7	12.0	16.0	Q1
INA2128UA/1K	SOIC	DW	16	1000	330.0	16.4	10.75	10.7	2.7	12.0	16.0	Q1
INA2128UA/1K	SOIC	DW	16	1000	330.0	16.4	10.75	10.7	2.7	12.0	16.0	Q1

PACKAGE MATERIALS INFORMATION

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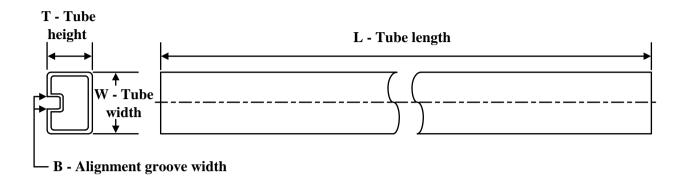
*All dimensions are nominal

	7 III GIITTOTTOTOTTO GITO TTOTTIITTGI							
	Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
	INA2128U/1K	SOIC	DW	16	1000	356.0	356.0	35.0
	INA2128U/1K	SOIC	DW	16	1000	350.0	350.0	43.0
ı	INA2128UA/1K	SOIC	DW	16	1000	350.0	350.0	43.0
	INA2128UA/1K	SOIC	DW	16	1000	356.0	356.0	35.0

PACKAGE MATERIALS INFORMATION

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TUBE



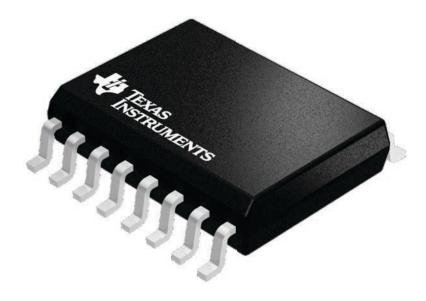
*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (µm)	B (mm)
INA2128U	DW	SOIC	16	40	507	12.83	5080	6.6
INA2128U	DW	SOIC	16	40	506.98	12.7	4826	6.6
INA2128UA	DW	SOIC	16	40	507	12.83	5080	6.6
INA2128UA	DW	SOIC	16	40	506.98	12.7	4826	6.6

7.5 x 10.3, 1.27 mm pitch

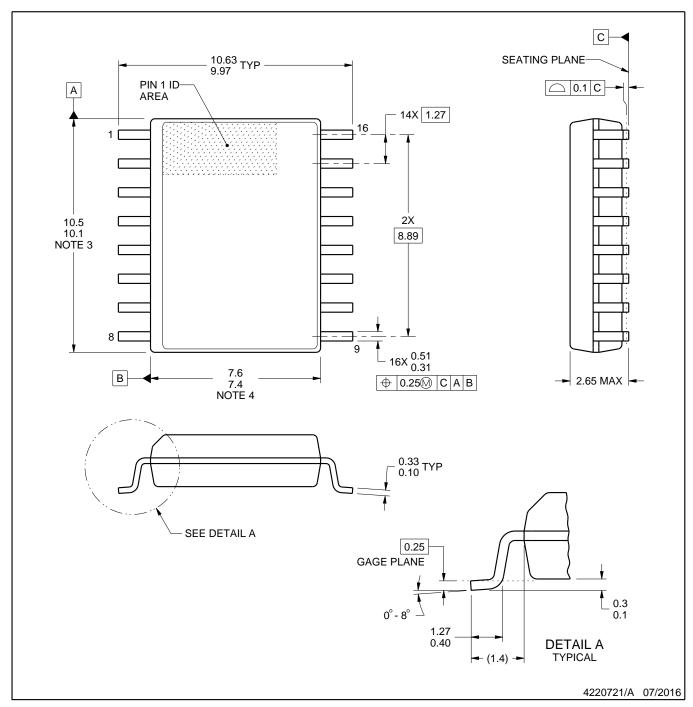
SMALL OUTLINE INTEGRATED CIRCUIT

This image is a representation of the package family, actual package may vary. Refer to the product data sheet for package details.





SOIC



NOTES:

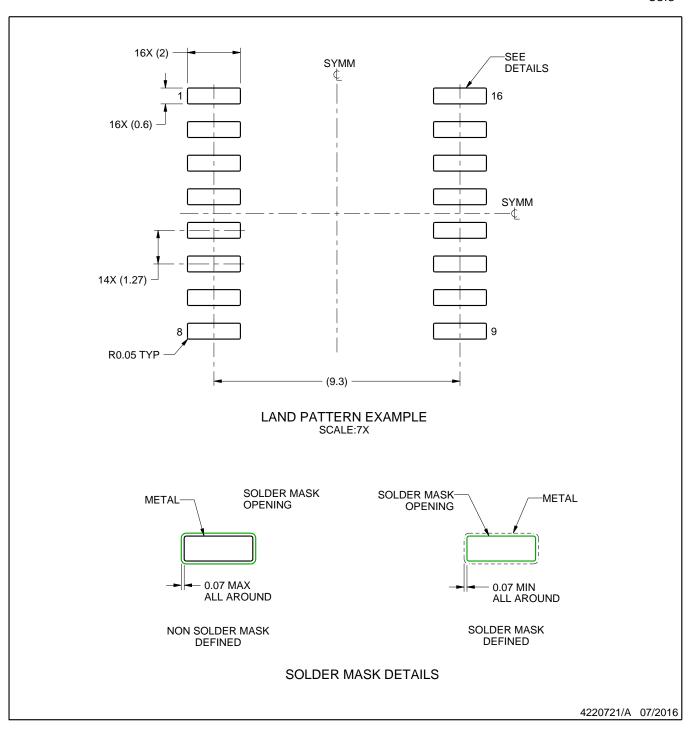
- 1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing
- per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm, per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm, per side.
- 5. Reference JEDEC registration MS-013.



SOIC



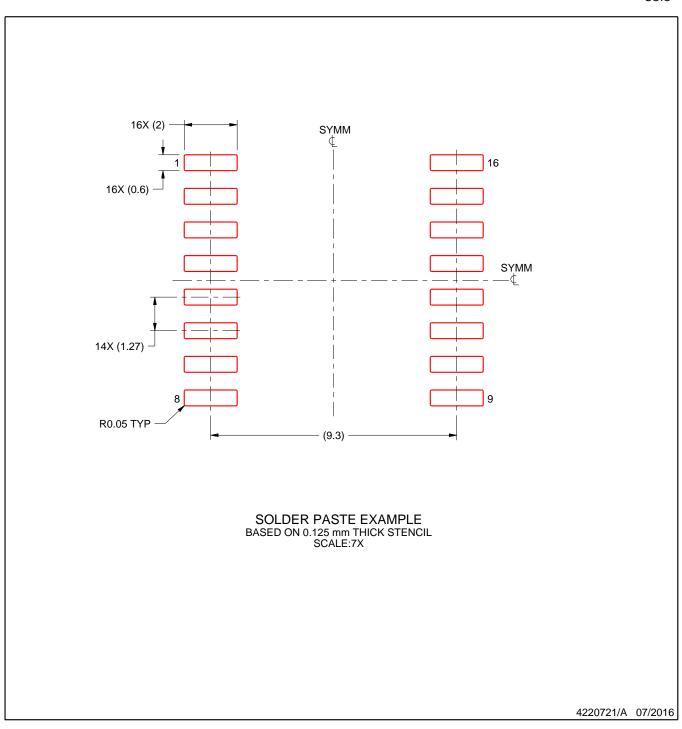
NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SOIC



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



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